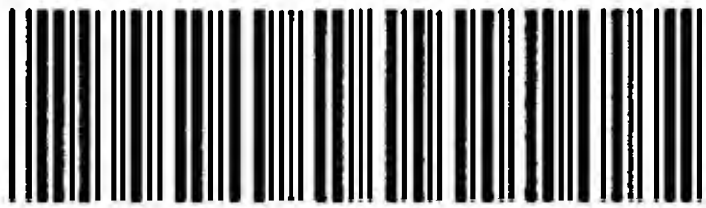


Search Notes



Application/Control No.

10/604,409

Examiner

Nathan W. Ha

Applicant(s)/Patent under Reexamination

LEE ET AL.

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
updated 257	686-691 700-704	3/1/05 1	us 1

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257 1	686-691 700-704	3/1/05 1	us 1

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
See alt. search report	3/1/05	us